

TLP183

Office Machine
Programmable Controllers
AC Adapter
I/O Interface Board

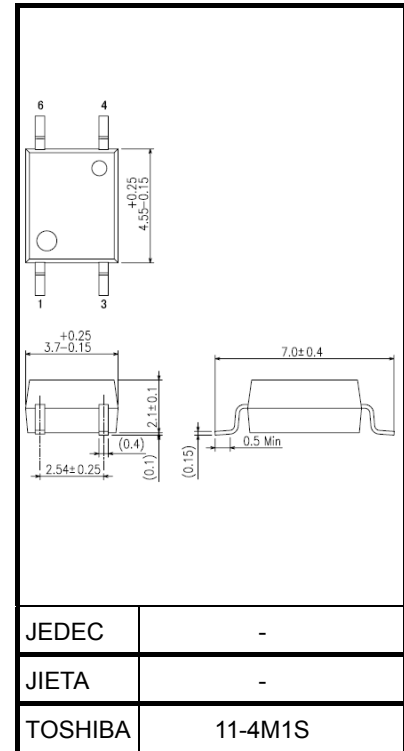
TLP183 consist of a photo transistor optically coupled to an InGaAs infrared emitting diode.

TLP183 is a low input type phototransistor coupler that housed in the very small and thin SO6 package. It is guaranteed wide operating temperature ($T_a = -55$ to $125\text{ }^{\circ}\text{C}$) and high isolation voltage (3750Vrms).

TLP183 is smaller than DIP package; it's suitable for high-density surface mounting applications such as programmable controllers

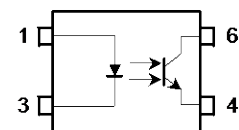
- Collector-emitter voltage: 80V (min)
- Current transfer ratio: 50% (min)
Rank GB: 100% (min)
- Isolation voltage: 3750Vrms (min)
- Operation Temperature: -55 to $125\text{ }^{\circ}\text{C}$
- Safety Standards
UL recognized: UL1577, File No. E67349
cUL approved: CSA Component Acceptance Service No. 5A
File No. E67349
- Option (V4) type
VDE approved: DIN EN60747-5-5, File No. 40009347
(Note): When a EN60747-5-5 approved type is needed,
Please designate "Option(V4)"
- Construction mechanical rating
Creepage distance : 5.0 mm(min)
Clearance : 5.0 mm(min)
Insulation thickness : 0.4 mm(min)

Unit: mm



Weight: 0.08 g (Typ.)

Pin Configuration



- 1: Anode
- 3: Cathode
- 4: Emitter
- 6: Collector

Current Transfer Ratio (Unless otherwise specified, Ta = 25°C)

Rank (Note1)	Test Condition	Current Transfer Ratio		Marking Of Classification	Unit
		I_C / I_F			
		Min	Max		
Blank	$I_F = 5 \text{ mA}, V_{CE} = 5 \text{ V}$	50	600	Blank, YE, GR, GB, BL, Y+, G, G+, B	%
	$I_F = 0.5 \text{ mA}, V_{CE} = 5 \text{ V}$				
Y	$I_F = 5 \text{ mA}, V_{CE} = 5 \text{ V}$	50	150	YE	
	$I_F = 0.5 \text{ mA}, V_{CE} = 5 \text{ V}$				
GR	$I_F = 5 \text{ mA}, V_{CE} = 5 \text{ V}$	100	300	GR	
	$I_F = 0.5 \text{ mA}, V_{CE} = 5 \text{ V}$				
GB	$I_F = 5 \text{ mA}, V_{CE} = 5 \text{ V}$	100	600	GB	
	$I_F = 0.5 \text{ mA}, V_{CE} = 5 \text{ V}$				
BL	$I_F = 5 \text{ mA}, V_{CE} = 5 \text{ V}$	200	600	BL	
	$I_F = 0.5 \text{ mA}, V_{CE} = 5 \text{ V}$				
YH	$I_F = 0.5 \text{ mA}, V_{CE} = 5 \text{ V}$	75	150	Y+	
GRL	$I_F = 0.5 \text{ mA}, V_{CE} = 5 \text{ V}$	100	200	G	
GRH	$I_F = 0.5 \text{ mA}, V_{CE} = 5 \text{ V}$	150	300	G+	
BLL	$I_F = 0.5 \text{ mA}, V_{CE} = 5 \text{ V}$	200	400	B	

Note1: Specify both the part number and a rank in this format when ordering

(e.g.) rank GB: TLP183 (GB,E)

For safety standard certification, however, specify the part number alone.

(e.g.) TLP183 (GB,E): TLP183

Absolute Maximum Ratings (Unless otherwise specified, Ta = 25°C)

Characteristic		Symbol	Note	Rating	Unit
LED	Input forward current	I_F		50	mA
	Input forward current derating (Ta ≥ 90°C)	$\Delta I_F / \Delta T_a$		-1.5	mA / °C
	Input forward current (Pulsed)	I_{FP}	(Note2)	1	A
	Input reverse voltage	V_R		5	V
	Junction temperature	T_j		125	°C
Detector	Collector-emitter voltage	V_{CEO}		80	V
	Emitter-collector voltage	V_{ECO}		7	V
	Collector current	I_C		50	mA
	Collector power dissipation	P_C		150	mW
	Collector power dissipation derating (Ta ≥ 25°C)	$\Delta P_C / \Delta T_a$		-1.5	mW / °C
	Junction temperature	T_j		125	°C
Operating temperature range		T_{opr}		-55 to 125	°C
Storage temperature range		T_{stg}		-55 to 125	°C
Lead soldering temperature		T_{sol}		260 (10s)	°C
Total package power dissipation		P_T		200	mW
Total package power dissipation derating (Ta ≥ 25°C)		$\Delta P_T / \Delta T_a$		-2.0	mW / °C
Isolation voltage		BV_S	(Note 3)	3750	V_{rms}

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: Pulse width ≤ 100 μs, f=100 Hz

Note 3: AC, 1min., R.H.≤ 60%, Device considered a two terminal device: LED side pins shorted together and detector side pins shorted together.

Individual Electrical Characteristics (Unless otherwise specified, Ta = 25°C)

Characteristic		Symbol	Test Condition	Min	Typ.	Max	Unit
LED	Input forward voltage	V _F	I _F = 10 mA	1.1	1.25	1.4	V
	Input reverse current	I _R	V _R = 5 V	-	-	5	μA
	Input capacitance	C _T	V = 0V, f = 1 MHz	-	30	-	pF
Detector	Collector–emitter breakdown voltage	V _(BR) CEO	I _C = 0.5 mA	80	-	-	V
	Emitter–collector breakdown voltage	V _(BR) ECO	I _E = 0.1 mA	7	-	-	V
	Dark current	I _{DARK}	V _{CE} = 48 V	-	0.01	0.08	μA
			V _{CE} = 48 V, Ta = 85°C	-	2	50	μA
	Collector-emitter capacitance	C _{CE}	V = 0V, f = 1 MHz	-	10	-	pF

Coupled Electrical Characteristics (Unless otherwise specified, Ta = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ.	Max	Unit
Current transfer ratio	I_C / I_F	$I_F = 5 \text{ mA}$, $V_{CE} = 5 \text{ V}$ Rank GB	50	-	600	%
			100	-	600	
		$I_F = 0.5 \text{ mA}$, $V_{CE} = 5 \text{ V}$ Rank GB	50	-	600	
			100	-	600	
Saturated current transfer ratio	$I_C / I_F (\text{sat})$	$I_F = 1 \text{ mA}$, $V_{CE} = 0.4 \text{ V}$ Rank GB	-	60	-	%
			30	-	-	
Collector-emitter saturation voltage	$V_{CE} (\text{sat})$	$I_C = 2.4 \text{ mA}$, $I_F = 8 \text{ mA}$	-	-	0.3	V
		$I_C = 0.2 \text{ mA}$, $I_F = 1 \text{ mA}$ Rank GB	-	0.2	-	
			-	-	0.3	
Off-state collector current	$I_C (\text{off})$	$V_F = 0.7\text{V}$, $V_{CE} = 48 \text{ V}$	-	-	10	μA

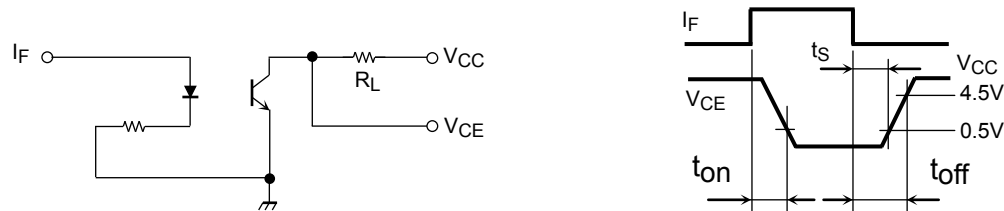
Isolation Characteristics (Unless otherwise specified, Ta = 25°C)

Characteristic	Symbol	Test Condition	Min	Typ.	Max	Unit
Total capacitance (input to output)	C_S	$V_S = 0\text{V}$, $f = 1 \text{ MHz}$	-	0.8	-	pF
Isolation resistance	R_S	$V_S = 500 \text{ V}$, R.H. $\leq 60\%$	1×10^{12}	10^{14}	-	Ω
Isolation voltage	BV_S	AC, 1 minute	3750	-	-	V_{rms}
		AC, 1 second, in oil	-	10000	-	
		DC, 1 minute, in oil	-	10000	-	V_{dc}

Switching Characteristics (Unless otherwise specified, Ta = 25°C)

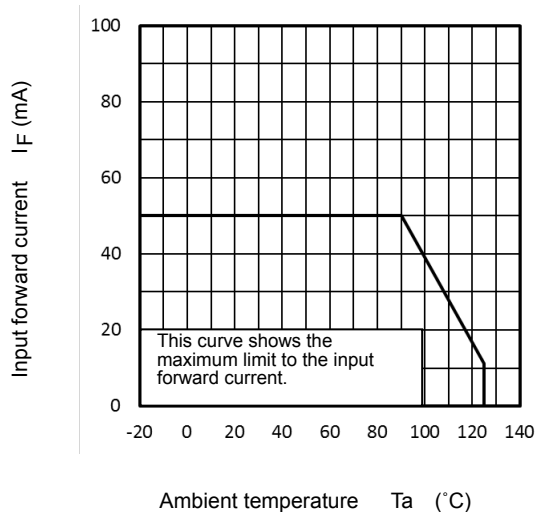
Characteristic	Symbol	Test Condition	Min	Typ.	Max	Unit
Rise time	t_r	$V_{CC} = 10\text{ V}$, $I_C = 2\text{ mA}$ $R_L = 100\Omega$	-	2	-	μs
Fall time	t_f		-	3	-	
Turn-on time	t_{on}		-	3	-	
Turn-off time	t_{off}		-	3	-	
Turn-on time	t_{on}	$R_L = 1.9\text{ k}\Omega$ $V_{CC} = 5\text{ V}$, $I_F = 16\text{ mA}$ (Fig.1)	-	0.4	-	μs
Storage time	t_s		-	20	-	
Turn-off time	t_{off}		-	35	-	
Turn-on time	t_{on}	$R_L = 1.9\text{ k}\Omega$ $V_{CC} = 5\text{ V}$, $I_F = 16\text{ mA}$ (Fig.1)	-	4	-	μs
Storage time	t_s		-	7	-	
Turn-off time	t_{off}		-	30	-	

Fig. 1 Switching time test circuit

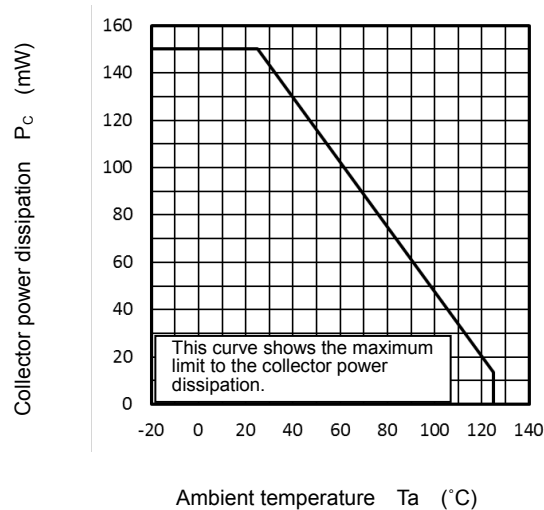


Characteristics Curves (Note)

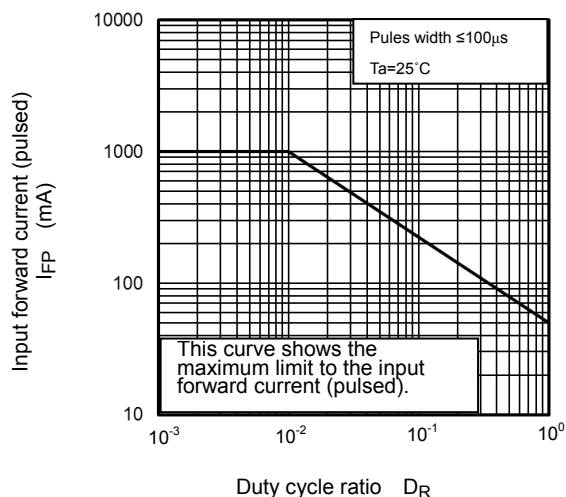
$I_F - T_a$



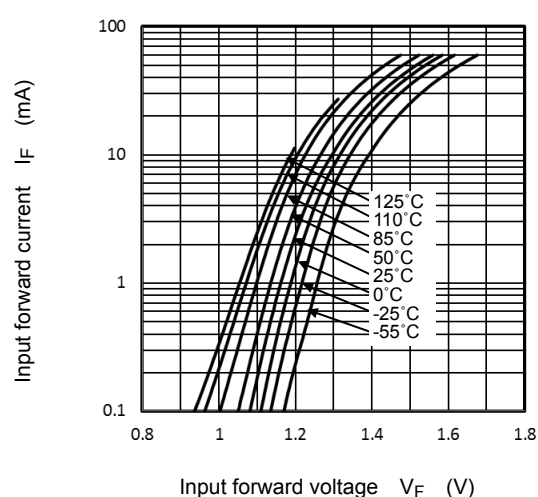
$P_C - T_a$



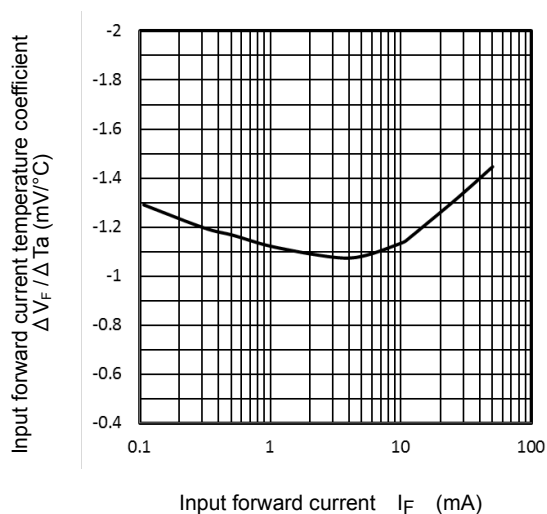
$I_{FP} - D_R$



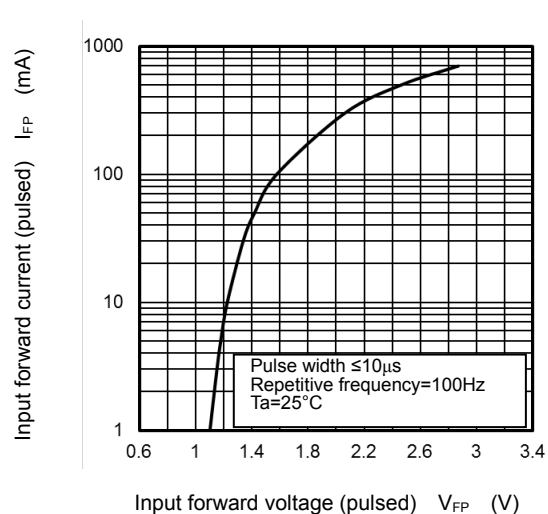
$I_F - V_F$



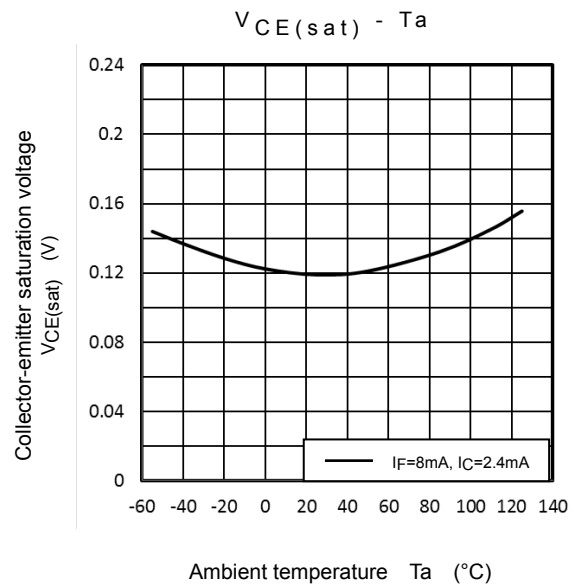
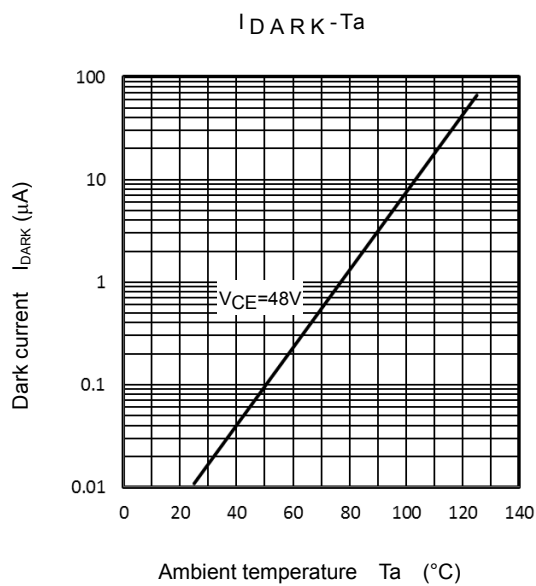
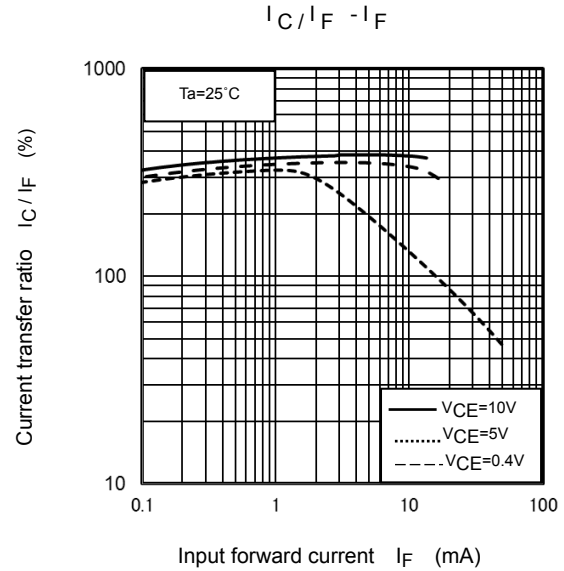
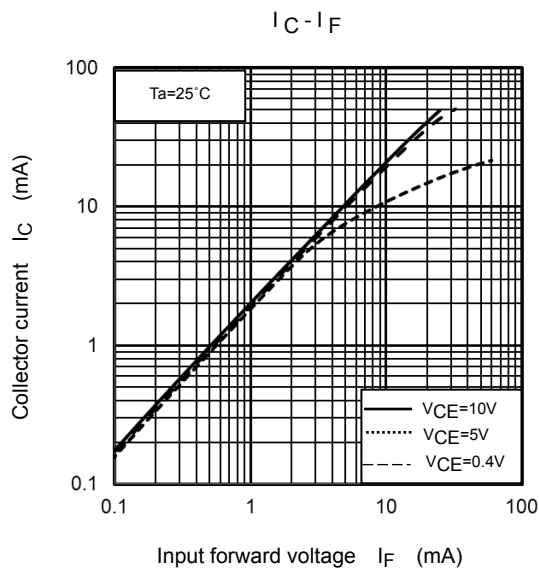
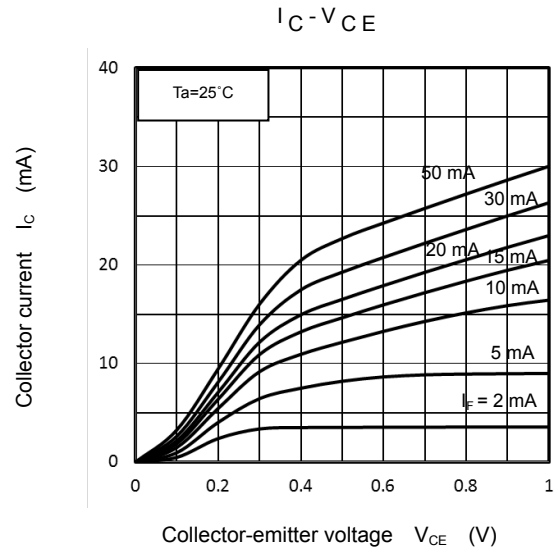
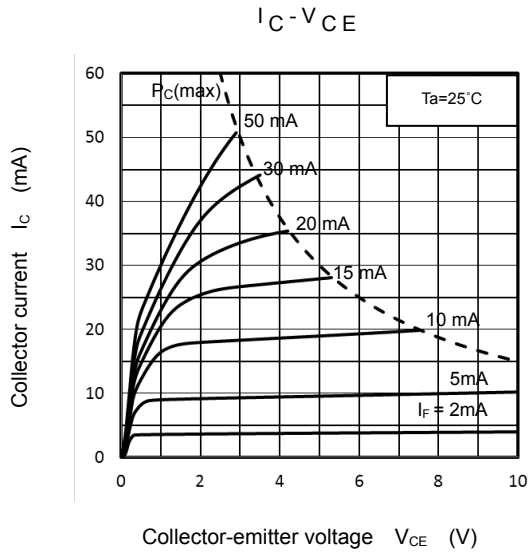
$\Delta V_F / \Delta T_a - I_F$



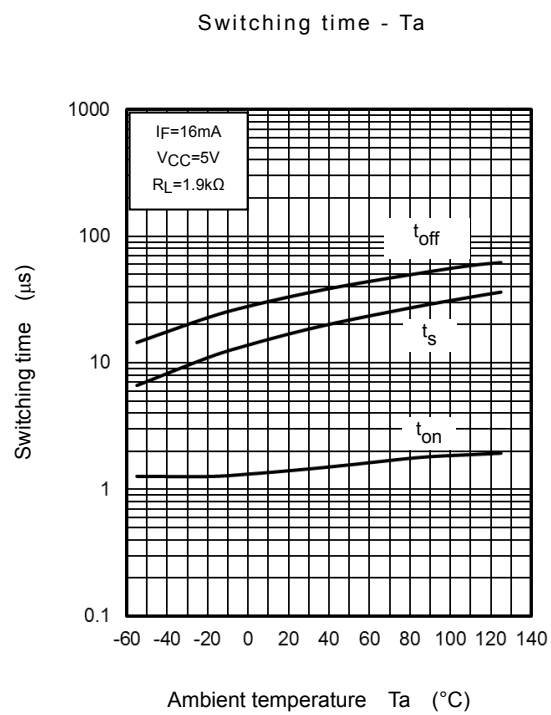
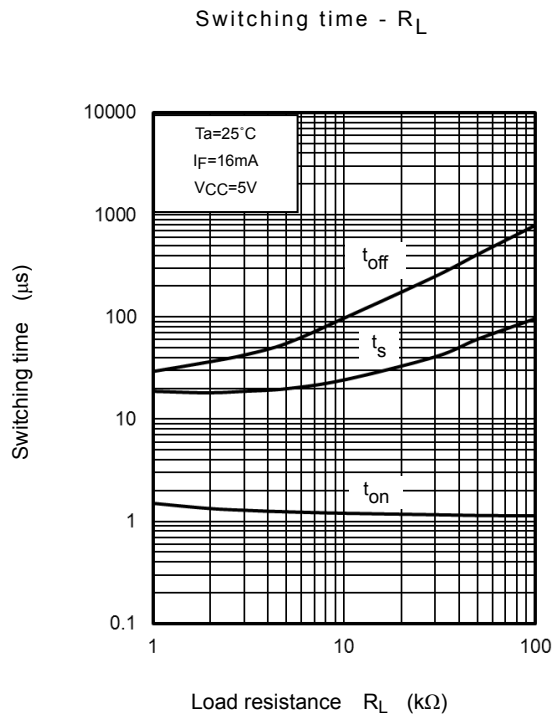
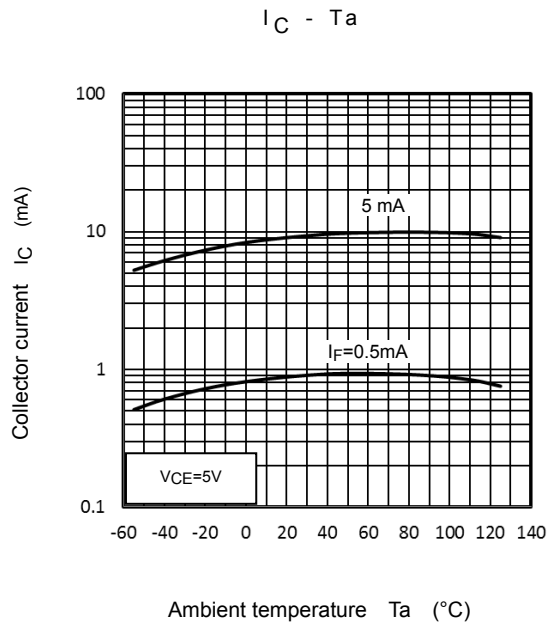
$I_{FP} - V_{FP}$



Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted



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Soldering and Storage

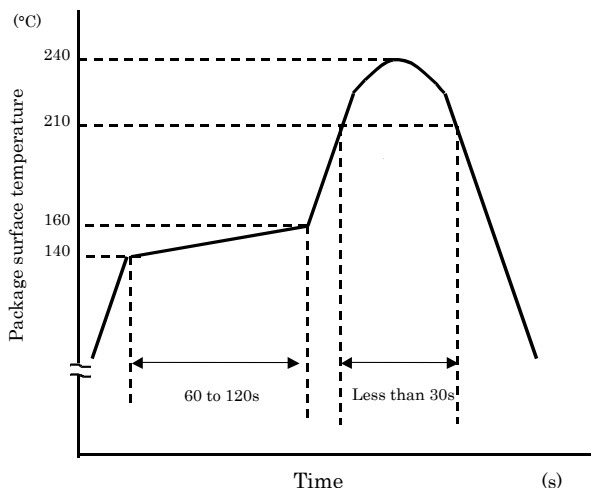
1. Soldering

1.1 Soldering

When using a soldering iron or medium infrared ray/hot air reflow, avoid a rise in device temperature as much as possible by observing the following conditions.

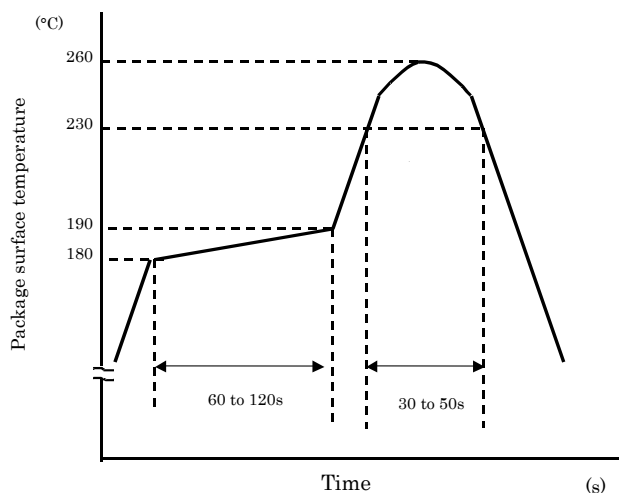
1) Using solder reflow

·Temperature profile example of lead (Pb) solder



This profile is based on the device's maximum heat resistance guaranteed value.
Set the preheat temperature/heating temperature to the optimum temperature corresponding to the solder paste type used by the customer within the described profile.

·Temperature profile example of using lead (Pb)-free solder



This profile is based on the device's maximum heat resistance guaranteed value.
Set the preheat temperature/heating temperature to the optimum temperature corresponding to the solder paste type used by the customer within the described profile.

Reflow soldering must be performed once or twice.

The mounting should be completed with the interval from the first to the last mountings being 2 weeks.

2) Using solder flow (for lead (Pb) solder, or lead (Pb)-free solder)

Please preheat it at 150°C between 60 and 120 seconds.

Complete soldering within 10 seconds below 260°C. Each pin may be heated at most once.

3) Using a soldering iron

Complete soldering within 10 seconds below 260°C, or within 3 seconds at 350°C. Each pin may be heated at most once.

2. Storage

- 1) Avoid storage locations where devices may be exposed to moisture or direct sunlight.
- 2) Follow the precautions printed on the packing label of the device for transportation and storage.
- 3) Keep the storage location temperature and humidity within a range of 5°C to 35°C and 45% to 75%, respectively.
- 4) Do not store the products in locations with poisonous gases (especially corrosive gases) or in dusty conditions.
- 5) Store the products in locations with minimal temperature fluctuations. Rapid temperature changes during storage can cause condensation, resulting in lead oxidation or corrosion, which will deteriorate the solderability of the leads.
- 6) When restoring devices after removal from their packing, use anti-static containers.
- 7) Do not allow loads to be applied directly to devices while they are in storage.
- 8) If devices have been stored for more than two years under normal storage conditions, it is recommended that you check the leads for ease of soldering prior to use.

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